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### What is "[Embedded - Microcontrollers](#)"?

"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

### Applications of "[Embedded - Microcontrollers](#)"

#### Details

Product Status	Active
Core Processor	STM8
Core Size	8-Bit
Speed	16MHz
Connectivity	I <sup>2</sup> C, IrDA, LINbus, SPI, UART/USART
Peripherals	Brown-out Detect/Reset, POR, PWM, WDT
Number of I/O	34
Program Memory Size	16KB (16K x 8)
Program Memory Type	FLASH
EEPROM Size	1K x 8
RAM Size	2K x 8
Voltage - Supply (Vcc/Vdd)	2.95V ~ 5.5V
Data Converters	A/D 9x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	44-LQFP
Supplier Device Package	-
Purchase URL	<a href="https://www.e-xfl.com/product-detail/stmicroelectronics/stm8s105s4t6c">https://www.e-xfl.com/product-detail/stmicroelectronics/stm8s105s4t6c</a>

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## 4.5 Clock controller

The clock controller distributes the system clock (fMASTER) coming from different oscillators to the core and the peripherals. It also manages clock gating for low power modes and ensures clock robustness.

### Features

- **Clock prescaler:** to get the best compromise between speed and current consumption the clock frequency to the CPU and peripherals can be adjusted by a programmable prescaler.
- **Safe clock switching:** clock sources can be changed safely on the fly in run mode through a configuration register. The clock signal is not switched until the new clock source is ready. The design guarantees glitch-free switching.
- **Clock management:** to reduce power consumption, the clock controller can stop the clock to the core, individual peripherals or memory.
- **Master clock sources:** four different clock sources can be used to drive the master clock:
  - 1-16 MHz high-speed external crystal (HSE)
  - Up to 16 MHz high-speed user-external clock (HSE user-ext)
  - 16 MHz high-speed internal RC oscillator (HSI)
  - 128 kHz low-speed internal RC (LSI)
- **Startup clock:** After reset, the microcontroller restarts by default with an internal 2 MHz clock (HSI/8). The prescaler ratio and clock source can be changed by the application program as soon as the code execution starts.
- **Clock security system (CSS):** This feature can be enabled by software. If an HSE clock failure occurs, the internal RC (16 MHz/8) is automatically selected by the CSS and an interrupt can optionally be generated.
- **Configurable main clock output (CCO):** This outputs an external clock for use by the application.

**Table 2. Peripheral clock gating bit assignments in CLK\_PCKENR1/2 registers**

Bit	Peripheral clock	Bit	Peripheral clock	Bit	Peripheral clock	Bit	Peripheral clock
PCKEN17	TIM1	PCKEN13	UART2	PCKEN27	Reserved	PCKEN23	ADC
PCKEN16	TIM3	PCKEN12	Reserved	PCKEN26	Reserved	PCKEN22	AWU
PCKEN15	TIM2	PCKEN11	SPI	PCKEN25	Reserved	PCKEN21	Reserved
PCKEN14	TIM4	PCKEN10	I2C	PCKEN24	Reserved	PCKEN20	Reserved

The IWDG time base spans from 60  $\mu$ s to 1 s.

## 4.8 Auto wakeup counter

- Used for auto wakeup from active halt mode,
- Clock source: Internal 128 kHz internal low frequency RC oscillator or external clock,
- LSI clock can be internally connected to TIM1 input capture channel 1 for calibration.

## 4.9 Beeper

The beeper function outputs a signal on the BEEP pin for sound generation. The signal is in the range of 1, 2 or 4 kHz.

The beeper output port is only available through the alternate function remap option bit AFR7.

## 4.10 TIM1 - 16-bit advanced control timer

This is a high-end timer designed for a wide range of control applications. With its complementary outputs, dead-time control and center-aligned PWM capability, the field of applications is extended to motor control, lighting and half-bridge driver

- 16-bit up, down and up/down autoreload counter with 16-bit prescaler
- Four independent capture/compare channels (CAPCOM) configurable as input capture, output compare, PWM generation (edge and center aligned mode) and single pulse mode output
- Synchronization module to control the timer with external signals
- Break input to force the timer outputs into a defined state
- Three complementary outputs with adjustable dead time
- Encoder mode
- Interrupt sources: 3 x input capture/output compare, 1 x overflow/update, 1 x break

## 4.11 TIM2, TIM3 - 16-bit general purpose timers

- 16-bit auto reload (AR) up-counter
- 15-bit prescaler adjustable to fixed power of 2 ratios 1...32768
- Timers with 3 or 2 individually configurable capture/compare channels
- PWM mode
- Interrupt sources: 2 or 3 x input capture/output compare, 1 x overflow/update

**LIN slave mode**

- Autonomous header handling - one single interrupt per valid message header
- Automatic baud rate synchronization - maximum tolerated initial clock deviation  $\pm 15\%$
- Synch delimiter checking
- 11-bit LIN synch break detection - break detection always active
- Parity check on the LIN identifier field
- LIN error management
- Hot plugging support

**4.14.2 SPI**

- Maximum speed: 8 Mbit/s ( $f_{MASTER}/2$ ) both for master and slave
- Full duplex synchronous transfers
- Simplex synchronous transfers on two lines with a possible bidirectional data line
- Master or slave operation - selectable by hardware or software
- CRC calculation
- 1 byte Tx and Rx buffer
- Slave/master selection input pin

**4.14.3 I<sup>2</sup>C**

- I<sup>2</sup>C master features:
  - Clock generation
  - Start and stop generation
- I<sup>2</sup>C slave features:
  - Programmable I2C address detection
  - Stop bit detection
- Generation and detection of 7-bit/10-bit addressing and general call
- Supports different communication speeds:
  - Standard speed (up to 100 kHz)
  - Fast speed (up to 400 kHz)

Table 6. Flash, data EEPROM and RAM boundary address

Memory area	Size (byte)	Start address	End address
Flash program memory	32 K	0x00 8000	0x00 FFFF
	16 K	0x00 8000	0x00 BFFF
RAM	2 K	0x00 0000	0x00 07FF
Data EEPROM	1024	0x00 4000	0x00 43FF

## 6.2 Register map

### 6.2.1 I/O port hardware register map

Table 7. I/O port hardware register map

Address	Block	Register label	Register name	Reset status
0x00 5000	Port A	PA_ODR	Port A data output latch register	0x00
0x00 5001		PA_IDR	Port A input pin value register	0xXX <sup>(1)</sup>
0x00 5002		PA_DDR	Port A data direction register	0x00
0x00 5003		PA_CR1	Port A control register 1	0x00
0x00 5004		PA_CR2	Port A control register 2	0x00
0x00 5005	Port B	PB_ODR	Port B data output latch register	0x00
0x00 5006		PB_IDR	Port B input pin value register	0xXX <sup>(1)</sup>
0x00 5007		PB_DDR	Port B data direction register	0x00
0x00 5008		PB_CR1	Port B control register 1	0x00
0x00 5009		PB_CR2	Port B control register 2	0x00
0x00 500A	Port C	PC_ODR	Port C data output latch register	0x00
0x00 500B		PC_IDR	Port C input pin value register	0xXX <sup>(1)</sup>
0x00 500C		PC_DDR	Port C data direction register	0x00
0x00 500D		PC_CR1	Port C control register 1	0x00
0x00 500E		PC_CR2	Port C control register 2	0x00
0x00 500F	Port D	PD_ODR	Port D data output latch register	0x00
0x00 5010		PD_IDR	Port D input pin value register	0xXX <sup>(1)</sup>
0x00 5011		PD_DDR	Port D data direction register	0x00
0x00 5012		PD_CR1	Port D control register 1	0x02
0x00 5013		PD_CR2	Port D control register 2	0x00

**Table 8. General hardware register map (continued)**

Address	Block	Register label	Register name	Reset status
0x00 5400	ADC1 cont'd	ADC_CSR	ADC control/status register	0x00
0x00 5401		ADC_CR1	ADC configuration register 1	0x00
0x00 5402		ADC_CR2	ADC configuration register 2	0x00
0x00 5403		ADC_CR3	ADC configuration register 3	0x00
0x00 5404		ADC_DRH	ADC data register high	0xXX
0x00 5405		ADC_DRL	ADC data register low	0xXX
0x00 5406		ADC_TDRH	ADC Schmitt trigger disable register high	0x00
0x00 5407		ADC_TDRL	ADC Schmitt trigger disable register low	0x00
0x00 5408		ADC_HTRH	ADC high threshold register high	0x03
0x00 5409		ADC_HTRL	ADC high threshold register low	0xFF
0x00 540A		ADC_LTRH	ADC low threshold register high	0x00
0x00 540B		ADC_LTRL	ADC low threshold register low	0x00
0x00 540C		ADC_AWSRH	ADC analog watchdog status register high	0x00
0x00 540D		ADC_AWSRL	ADC analog watchdog status register low	0x00
0x00 540E		ADC_AWCRH	ADC analog watchdog control register high	0x00
0x00 540F		ADC_AWCRL	ADC analog watchdog control register low	0x00
0x00 5410 to 0x00 57FF	Reserved area (1008 byte)			

1. Depends on the previous reset source.
2. Write-only register.

Table 10. Interrupt mapping (continued)

IRQ no.	Source block	Description	Wakeup from halt mode	Wakeup from active-halt mode	Vector address
20	UART2	Tx complete	-	-	0x00 8058
21	UART2	Receive register DATA FULL	-	-	0x00 805C
22	ADC1	ADC1 end of conversion/ analog watchdog interrupt	-	-	0x00 8060
23	TIM4	TIM4 update/ overflow	-	-	0x00 8064
24	Flash	EOP/WR_PG_DIS	-	-	0x00 8068
Reserved					0x00 806C to 0x00 807C

1. Except PA1.



## 10.2 Absolute maximum ratings

Stresses above those listed as ‘absolute maximum ratings’ may cause permanent damage to the device. This is a stress rating only and functional operation of the device under these conditions is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

**Table 15. Voltage characteristics**

Symbol	Ratings	Min	Max	Unit
$V_{DDx} - V_{SS}$	Supply voltage (including $V_{DDA}$ and $V_{DDIO}$ ) <sup>(1)</sup>	-0.3	6.5	V
$V_{IN}$	Input voltage on true open drain pins (PE1, PE2) <sup>(2)</sup>	$V_{SS} - 0.3$	6.5	V
	Input voltage on any other pin <sup>(2)</sup>	$V_{SS} - 0.3$	$V_{DD} + 0.3$	
$ V_{DDx} - V_{DD} $	Variations between different power pins	-	50	mV
$ V_{SSx} - V_{SS} $	Variations between all the different ground pins	-	50	
$V_{ESD}$	Electrostatic discharge voltage	see <a href="#">Absolute maximum ratings (electrical sensitivity) on page 89</a>		

1. All power ( $V_{DD}$ ) and ground ( $V_{SS}$ ) pins must always be connected to the external power supply
2.  $I_{INJ(PIN)}$  must never be exceeded. This is implicitly insured if  $V_{IN}$  maximum is respected. If  $V_{IN}$  maximum cannot be respected, the injection current must be limited externally to the  $I_{INJ(PIN)}$  value. A positive injection is induced by  $V_{IN} > V_{DD}$  while a negative injection is induced by  $V_{IN} < V_{SS}$ . For true open-drain pads, there is no positive injection current, and the corresponding  $V_{IN}$  maximum must always be respected

**Table 16. Current characteristics**

Symbol	Ratings	Max. <sup>(1)</sup>	Unit
$I_{VDD}$	Total current into $V_{DD}$ power lines (source) <sup>(2)</sup>	100	mA
$I_{VSS}$	Total current out of $V_{SS}$ ground lines (sink) <sup>(1)</sup>	80	
$I_{IO}$	Output current sunk by any I/O and control pin	20	
	Output current source by any I/Os and control pin	-20	
$\Sigma I_{IO}$	Total output current sourced (sum of all I/O and control pins) for devices with two $V_{DDIO}$ pins <sup>(3)</sup>	200	
	Total output current sourced (sum of all I/O and control pins) for devices with one $V_{DDIO}$ pin <sup>(3)</sup>	100	
	Total output current sunk (sum of all I/O and control pins) for devices with two $V_{SSIO}$ pins <sup>(3)</sup>	160	
	Total output current sunk (sum of all I/O and control pins) for devices with one $V_{SSIO}$ pin <sup>(3)</sup>	80	
$I_{INJ(PIN)}$ <sup>(4) (5)</sup>	Injected current on NRST pin	±4	
	Injected current on OSCIN pin	±4	
	Injected current on any other pin <sup>(6)</sup>	±4	
$\Sigma I_{INJ(PIN)}$ <sup>(4)</sup>	Total injected current (sum of all I/O and control pins) <sup>(6)</sup>	±20	

1. Data based on characterization results, not tested in production.
2. All power ( $V_{DD}$ ,  $V_{DDIO}$ ,  $V_{DDA}$ ) and ground ( $V_{SS}$ ,  $V_{SSIO}$ ,  $V_{SSA}$ ) pins must always be connected to the external supply.

Figure 14. Typ  $I_{DD(RUN)}$  vs.  $f_{CPU}$  HSE user external clock,  $V_{DD} = 5\text{ V}$

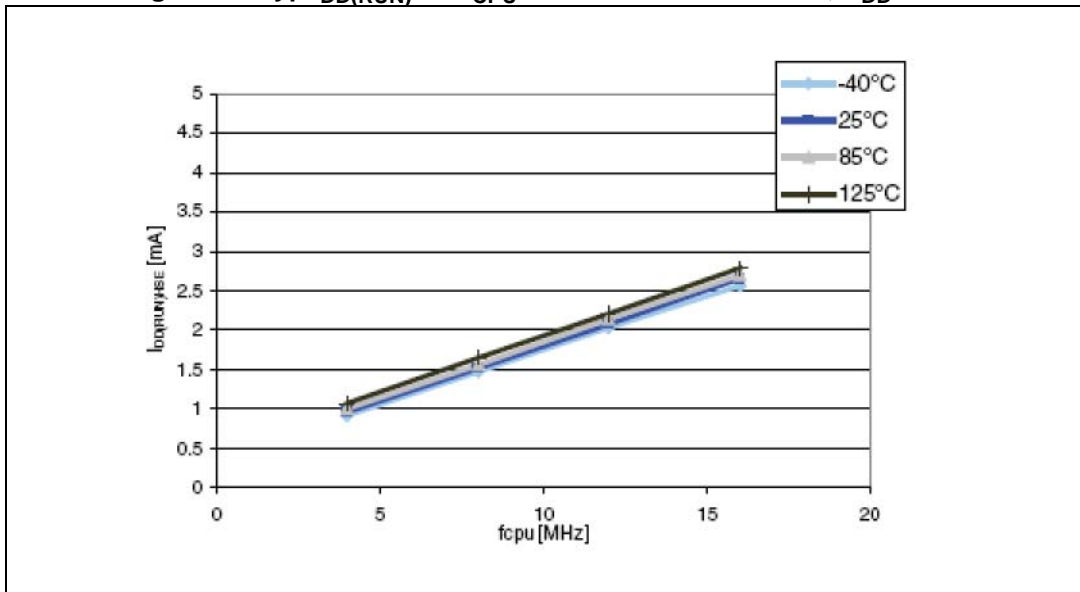
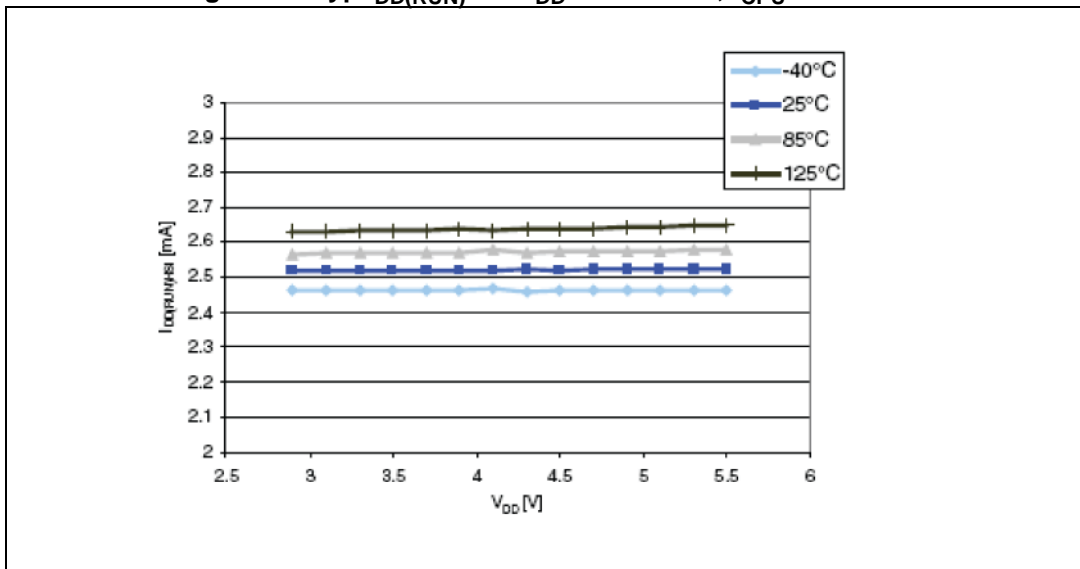


Figure 15. Typ  $I_{DD(RUN)}$  vs.  $V_{DD}$  HSI RC osc,  $f_{CPU} = 16\text{ MHz}$



### 10.3.3 External clock sources and timing characteristics

#### HSE user external clock

Subject to general operating conditions for  $V_{DD}$  and  $T_A$ .

**Table 31. HSE user external clock characteristics**

Symbol	Parameter	Conditions	Min	Max	Unit
$f_{HSE\_ext}$	User external clock source frequency	-	0	16	MHz
$V_{HSEH}^{(1)}$	OSCIN input pin high level voltage	-	$0.7 \times V_{DD}$	$V_{DD} + 0.3 V$	V
$V_{HSEL}^{(1)}$	OSCIN input pin low level voltage	-	$V_{SS}$	$0.3 \times V_{DD}$	
$I_{LEAK\_HSE}$	OSCIN input leakage current	$V_{SS} < V_{IN} < V_{DD}$	-1	+1	$\mu A$

1. Data based on characterization results, not tested in production.

**Figure 19. HSE external clock source**

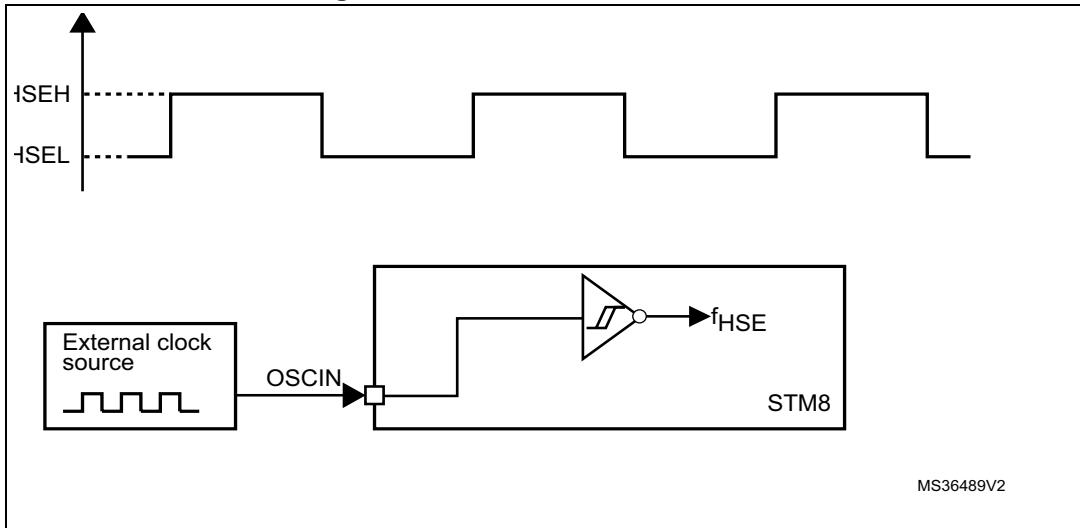
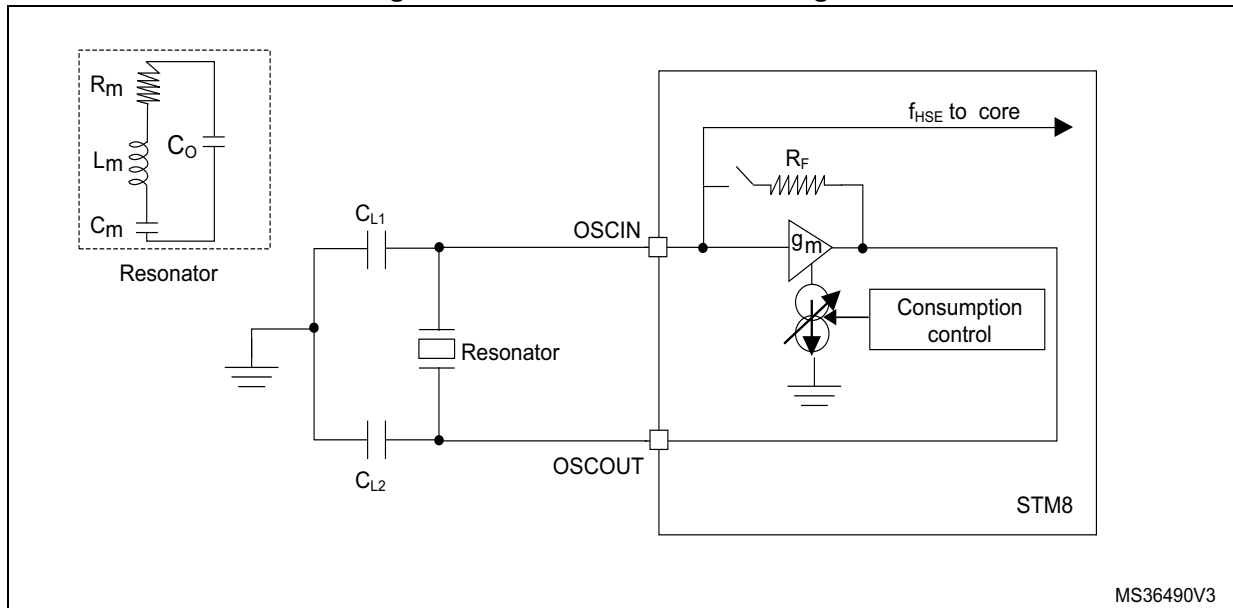


Figure 20. HSE oscillator circuit diagram



**HSE oscillator critical  $g_m$  equation**

$$g_{m\text{crit}} = (2 \times \Pi \times f_{\text{HSE}})^2 \times R_m(2C_o + C)^2$$

- $R_m$ : Notional resistance (see crystal specification)
- $L_m$ : Notional inductance (see crystal specification)
- $C_m$ : Notional capacitance (see crystal specification)
- $C_o$ : Shunt capacitance (see crystal specification)
- $C_{L1} = C_{L2} = C$ : Grounded external capacitance
- $g_m \gg g_{m\text{crit}}$

### 10.3.5 Memory characteristics

#### RAM and hardware registers

**Table 35. RAM and hardware registers**

Symbol	Parameter	Conditions	Min	Unit
V <sub>RM</sub>	Data retention mode <sup>(1)</sup>	Halt mode (or reset)	V <sub>IT-max</sub> <sup>(2)</sup>	V

1. Minimum supply voltage without losing data stored in RAM (in halt mode or under reset) or in hardware registers (only in halt mode). Guaranteed by design, not tested in production.

2. Refer to [Section 10.3: Operating conditions](#) for the value of V<sub>IT-max</sub>.

#### Flash program memory/data EEPROM memory

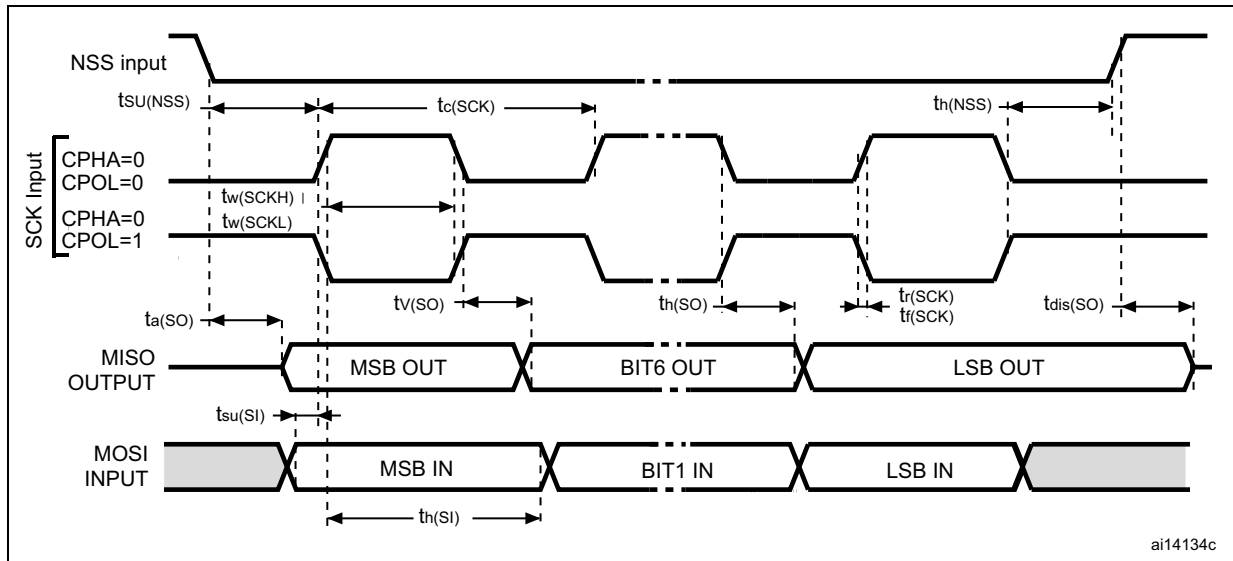
**Table 36. Flash program memory/data EEPROM memory**

Symbol	Parameter	Conditions	Min <sup>(1)</sup>	Typ	Max	Unit
V <sub>DD</sub>	Operating voltage (all modes, execution/write/erase)	f <sub>CPU</sub> ≤ 16 MHz	2.95	-	5.5	V
t <sub>prog</sub>	Standard programming time (including erase) for byte/word/block (1 byte/4 byte/128 byte)	-	-	6	6.6	ms
	Fast programming time for 1 block (128 byte)	-	-	3	3.33	
t <sub>erase</sub>	Erase time for 1 block (128 byte)	-	-	3	3.33	
N <sub>RW</sub>	Erase/write cycles (program memory) <sup>(2)</sup>	T <sub>A</sub> = +85 °C	10k	-	-	cycle
	Erase/write cycles (data memory) <sup>(2)</sup>	T <sub>A</sub> = +125 °C	300k	1M	-	
t <sub>RET</sub>	Data retention (program and data memory) after 10k erase/write cycles at T <sub>A</sub> = +55 °C	T <sub>RET</sub> = 55 °C	20	-	-	year
	Data retention (data memory) after 300k erase/write cycles at T <sub>A</sub> = +125 °C	T <sub>RET</sub> = 85 °C	1	-	-	
I <sub>DD</sub>	Supply current (Flash programming or erasing for 1 to 128 byte)	-	-	2	-	mA

1. Data based on characterization results, not tested in production.

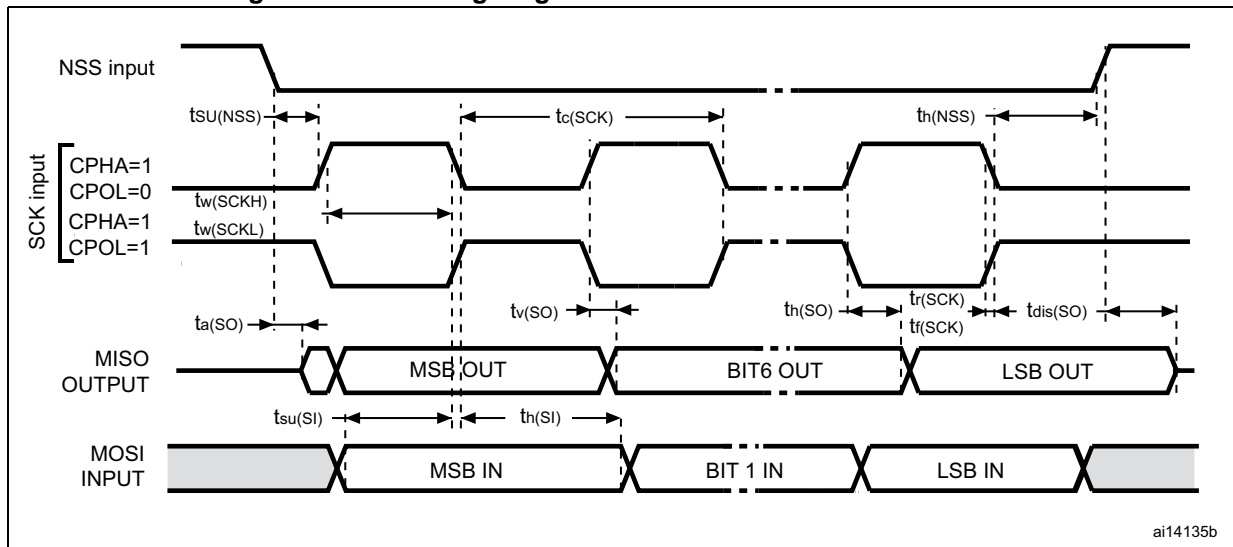
2. The physical granularity of the memory is 4 byte, so cycling is performed on 4 byte even when a write/erase operation addresses a single byte.

Figure 41. SPI timing diagram where slave mode and CPHA = 0



1. Measurement points are at CMOS levels: 0.3 V<sub>DD</sub> and 0.7 V<sub>DD</sub>.

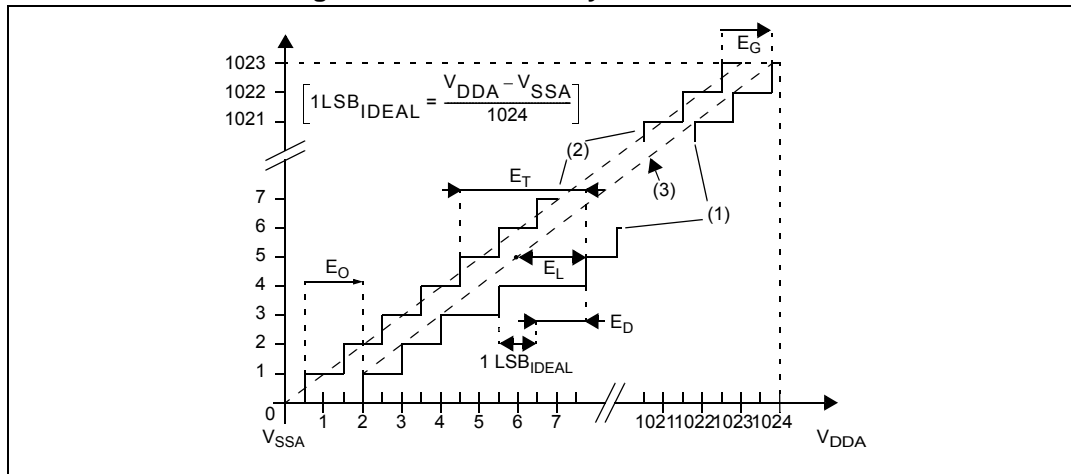
Figure 42. SPI timing diagram where slave mode and CPHA = 1



1. Measurement points are at CMOS levels: 0.3 V<sub>DD</sub> and 0.7 V<sub>DD</sub>.

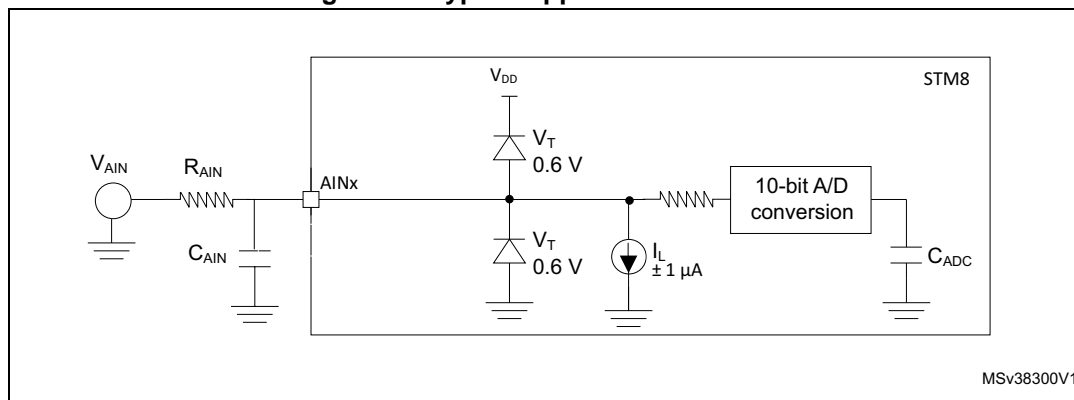
- ADC accuracy vs. negative injection current: Injecting negative current on any of the analog input pins should be avoided as this significantly reduces the accuracy of the conversion being performed on another analog input. It is recommended to add a Schottky diode (pin to ground) to standard analog pins which may potentially inject negative current. Any positive injection current within the limits specified for  $I_{INJ(PIN)}$  and  $\Sigma I_{INJ(PIN)}$  in [Section 10.3.6](#) does not affect the ADC accuracy.

Figure 45. ADC accuracy characteristics



- Example of an actual transfer curve
  - The ideal transfer curve
  - End point correlation line
- $E_T$  = Total unadjusted error: maximum deviation between the actual and the ideal transfer curves.  
 $E_O$  = Offset error: deviation between the first actual transition and the first ideal one.  
 $E_G$  = Gain error: deviation between the last ideal transition and the last actual one.  
 $E_D$  = Differential linearity error: maximum deviation between actual steps and the ideal one.  
 $E_L$  = Integral linearity error: maximum deviation between any actual transition and the end point correlation line.

Figure 46. Typical application with ADC



- Legend:  $R_{AIN}$  = external resistance,  $C_{AIN}$  = capacitors,  $C_{s\text{amp}}$  = internal sample and hold capacitor.

1. Data obtained with HSI clock configuration, after applying the hardware recommendations described in AN2860 (EMC guidelines for STM8S microcontrollers).

**Electromagnetic interference (EMI)**

Based on a simple application running on the product (toggling 2 LEDs through the I/O ports), the product is monitored in terms of emission. This emission test is in line with the norm IEC 61967-2 which specifies the board and the loading of each pin.

**Table 48. EMI data**

Symbol	Parameter	Conditions				Unit
		General conditions	Monitored frequency band	Max $f_{HSE}/f_{CPU}^{(1)}$		
				8 MHz/8 MHz	8 MHz/16 MHz	
S <sub>EMI</sub>	Peak level	V <sub>DD</sub> = 5 V, T <sub>A</sub> = 25 °C, LQFP48 package. Conforming to IEC 61967-2	0.1 MHz to 30 MHz	13	14	dBµV
			30 MHz to 130 MHz	23	19	
			130 MHz to 1 GHz	-4.0	-4.0	
	EMI level	EMI level	2.0	1.5	-	

1. Data based on characterization results, not tested in production.

**Absolute maximum ratings (electrical sensitivity)**

Based on two different tests (ESD, DLU and LU) using specific measurement methods, the product is stressed to determine its performance in terms of electrical sensitivity. For more details, refer to the application note AN1181.

**Electrostatic discharge (ESD)**

Electrostatic discharges (a positive then a negative pulse separated by 1 second) are applied to the pins of each sample according to each pin combination. The sample size depends on the number of supply pins in the device (3 parts x (n+1) supply pin). One model can be simulated: Human body model. This test conforms to the JESD22-A114A/A115A standard. For more details, refer to the application note AN1181.

**Table 49. ESD absolute maximum ratings**

Symbol	Ratings	Conditions	Class	Maximum value <sup>(1)</sup>	Unit
V <sub>ESD(HBM)</sub>	Electrostatic discharge voltage (Human body model)	T <sub>A</sub> = 25°C, conforming to JESD22-A114	A	2000	V
V <sub>ESD(CDM)</sub>	Electrostatic discharge voltage (Charge device model)	T <sub>A</sub> = 25°C, conforming to SD22-C101	IV	1000	

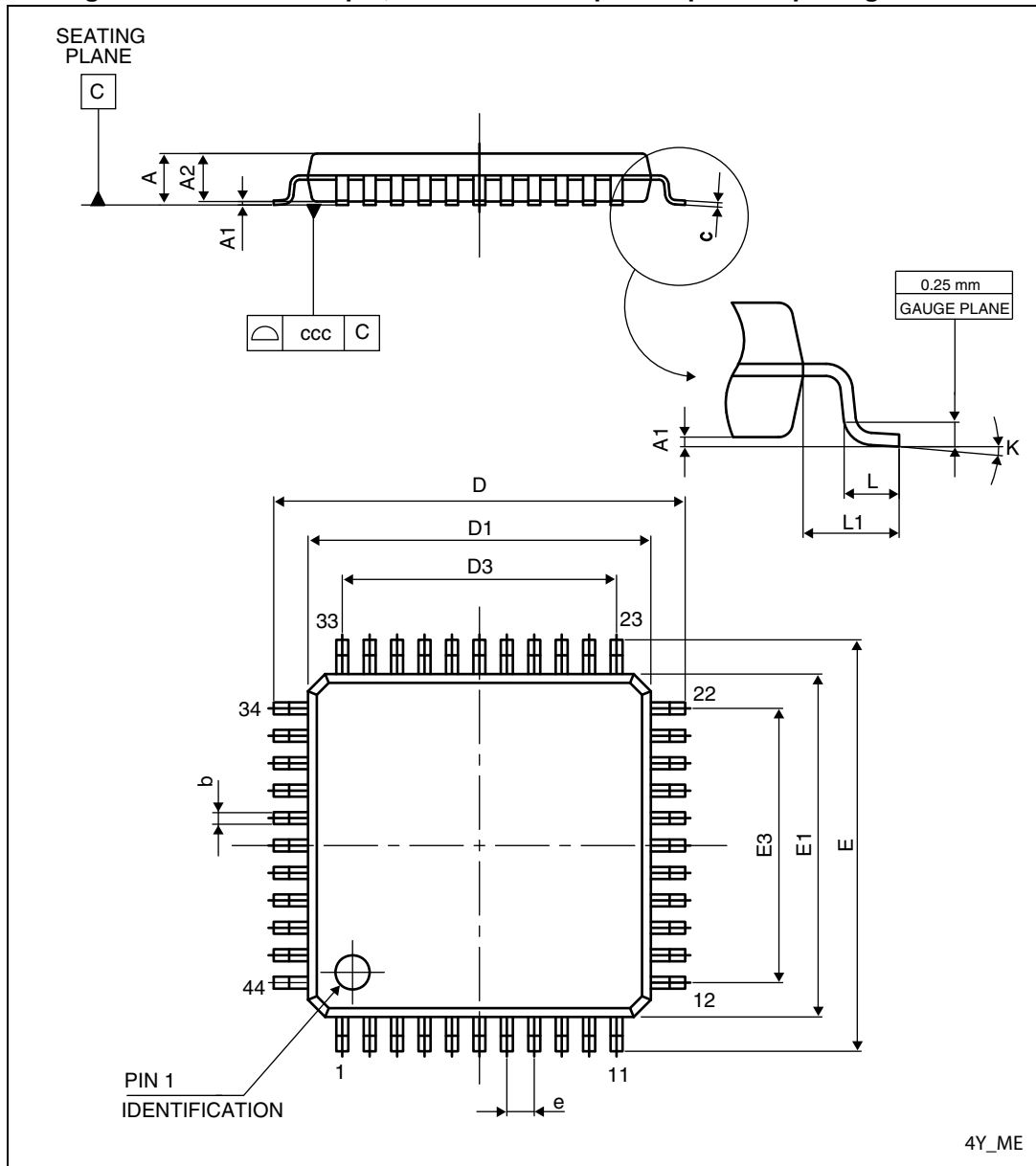
1. Data based on characterization results, not tested in production



usage will not be at ST charge. In no event, ST will be liable for any customer usage of these engineering samples in production. ST Quality has to be contacted prior to any decision to use these Engineering Samples to run qualification activity.

## 11.2 LQFP44 package information

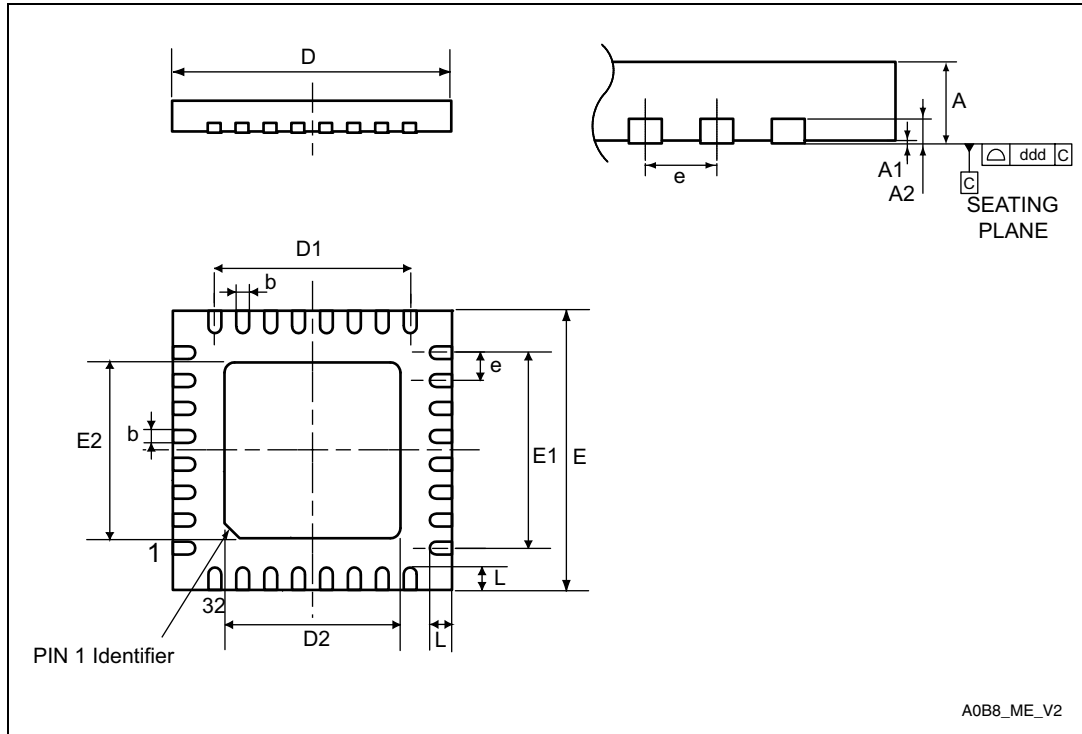
Figure 50. LQFP44 - 44-pin, 10 x 10 mm low-profile quad flat package outline



1. Drawing is not to scale.

### 11.4 UFQFPN32 package information

Figure 56. UFQFPN32 - 32-pin, 5x5 mm, 0.5 mm pitch ultra thin fine pitch quad flat package outline



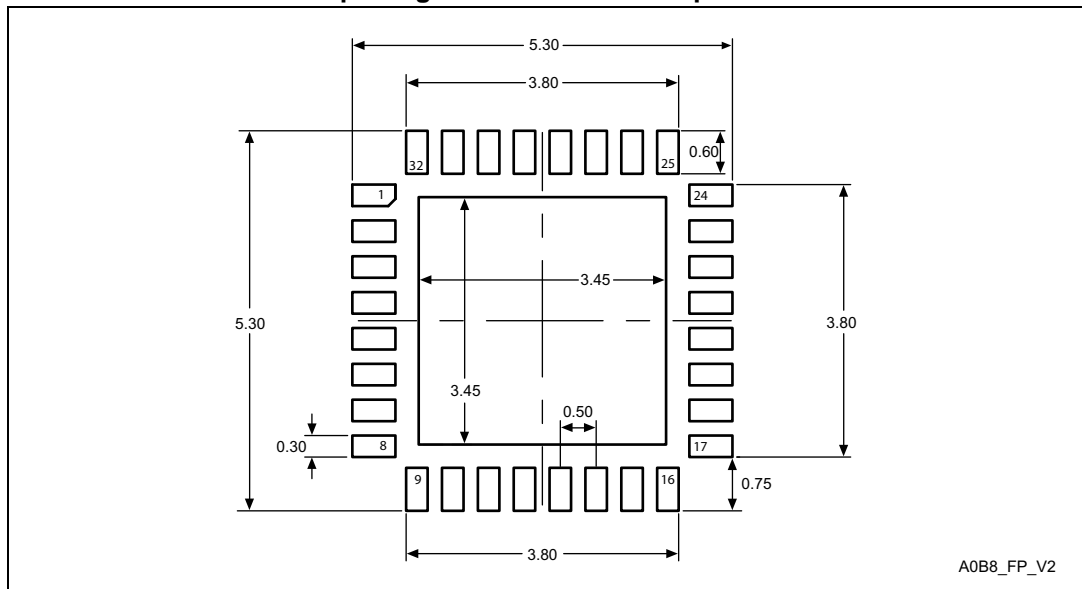
1. Drawing is not to scale.
2. All leads/pads should be soldered to the PCB to improve the lead/pad solder joint life.
3. There is an exposed die pad on the underside of the UFQFPN package. It is recommended to connect and solder this backside pad to PCB ground.
4. Dimensions are in millimeters.

**Table 54. UFQFPN32 - 32-pin, 5x5 mm, 0.5 mm pitch ultra thin fine pitch quad flat package mechanical data**

Symbol	millimeters			inches <sup>(1)</sup>		
	Min	Typ	Max	Min	Typ	Max
A	0.500	0.550	0.600	0.0197	0.0217	0.0236
A1	0.000	0.020	0.050	0.0000	0.0008	0.0020
A3	-	0.152	-	-	0.0060	-
b	0.180	0.230	0.280	0.0071	0.0091	0.0110
D	4.900	5.000	5.100	0.1929	0.1969	0.2008
D1	3.400	3.500	3.600	0.1339	0.1378	0.1417
D2	3.400	3.500	3.600	0.1339	0.1378	0.1417
E	4.900	5.000	5.100	0.1929	0.1969	0.2008
E1	3.400	3.500	3.600	0.1339	0.1378	0.1417
E2	3.400	3.500	3.600	0.1339	0.1378	0.1417
e	-	0.500	-	-	0.0197	-
L	0.300	0.400	0.500	0.0118	0.0157	0.0197
ddd	-	-	0.080	-	-	0.0031

1. Values in inches are converted from mm and rounded to 4 decimal digits.

**Figure 57. UFQFPN32 - 32-pin, 5 x 5 mm, 0.5 mm pitch ultra thin fine pitch quad flat package recommended footprint**



1. Dimensions are expressed in millimeters.

AFR4 (check only one option)	<input type="checkbox"/> 0: Remapping option inactive. Default alternate functions used. Refer to pinout description <input type="checkbox"/> 1: Port D7 alternate function = TIM1_CH4
AFR5 (check only one option)	<input type="checkbox"/> 0: Remapping option inactive. Default alternate functions used. Refer to pinout description <input type="checkbox"/> 1: Port B3 alternate function = TIM1_ETR, port B2 alternate function = TIM1_NCC3, port B1 alternate function = TIM1_CH2N, port B0 alternate function = TIM1_CH1N.
AFR6 (check only one option)	<input type="checkbox"/> 0: Remapping option inactive. Default alternate functions used. Refer to pinout description <input type="checkbox"/> 1: Port B5 alternate function = I2C_SDA, port B4 alternate function = I2C_SCL
AFR6 (check only one option)	<input type="checkbox"/> 0: Remapping option inactive. Default alternate functions used. Refer to pinout description <input type="checkbox"/> 1: Port D4 alternate function = BEEP.

**OPT3 watchdog**

WWDG_HALT (check only one option)	<input type="checkbox"/> 0: No reset generated on halt if WWDG active <input type="checkbox"/> 1: Reset generated on halt if WWDG active
WWDG_HW (check only one option)	<input type="checkbox"/> 0: WWDG activated by software <input type="checkbox"/> 1: WWDG activated by hardware
IWDG_HW (check only one option)	<input type="checkbox"/> 0: IWDG activated by software <input type="checkbox"/> 1: IWDG activated by hardware
LSI_EN (check only one option)	<input type="checkbox"/> 0: LSI clock is not available as CPU clock source <input type="checkbox"/> 1: LSI clock is available as CPU clock source
HSITRIM (check only one option)	<input type="checkbox"/> 0: 3-bit trimming supported in CLK_HSITRIMR register <input type="checkbox"/> 1: 4-bit trimming supported in CLK_HSITRIMR register

**OPT4 watchdog**

PRSC (check only one option)	<input type="checkbox"/> for 16 MHz to 128 kHz prescaler <input type="checkbox"/> for 8 MHz to 128 kHz prescaler <input type="checkbox"/> for 4 MHz to 128 kHz prescaler
CKAWUSEL (check only one option)	<input type="checkbox"/> LSI clock source selected for AWU <input type="checkbox"/> HSE clock with prescaler selected as clock source for AWU
EXTCLK (check only one option)	<input type="checkbox"/> External crystal connected to OSCIN/OSCOU <input type="checkbox"/> External signal on OSCIN

## 14.3 Programming tools

During the development cycle, STice provides in-circuit programming of the STM8 Flash microcontroller on the application board via the SWIM protocol. Additional tools include a low-cost in-circuit programmer as well as ST socket boards, which provide dedicated programming platforms with sockets for the STM8 programming.

For production environments, programmers will include a complete range of gang and automated programming solutions from third-party tool developers already supplying programmers for the STM8 family.